

Pixel2022

The Tenth International Workshop
on Semiconductor Pixel Detectors for Particles and Imaging

12–16 December 2022

La Fonda Hotel | Santa Fe, New Mexico, USA

10-ps timing with 3D-trench silicon pixels at extreme rates

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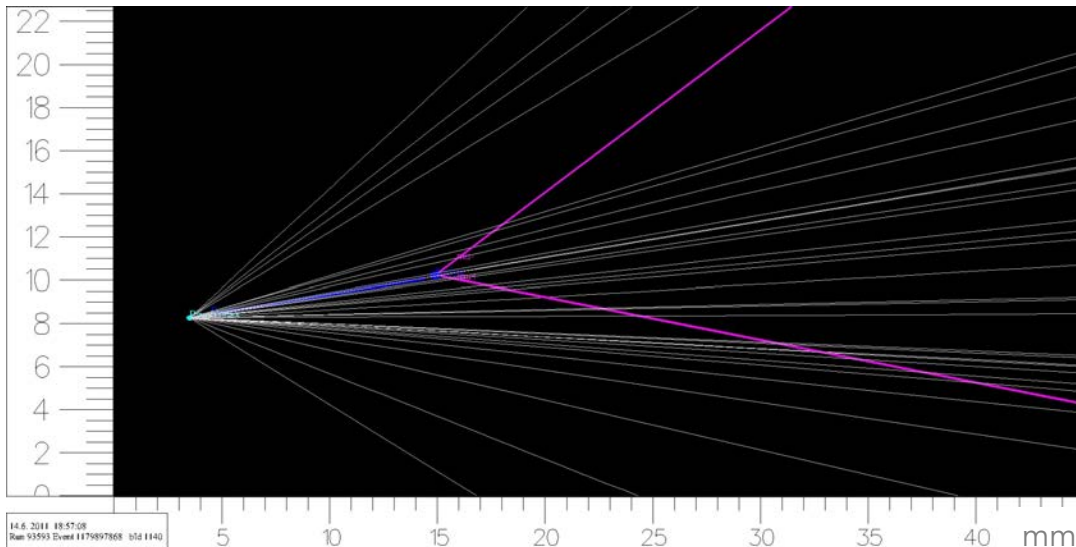
4D trackers/pixels: high density timing pixels

(beyond pile-up mitigation: when timing layers are not enough)



Plots from:
 Considerations for the VELO detector at the
 LHCb Upgrade II – CERN-LHCb-2022-001

B_{os} meson decaying into a μ^+ and μ^- pair



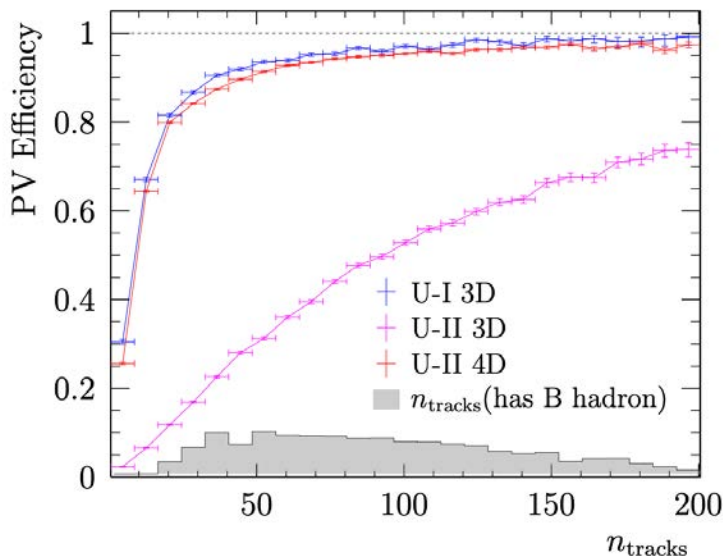
4D pixel:

A solid state pixel sensor (pitch $\approx 50 \mu\text{m}$) bearing time information

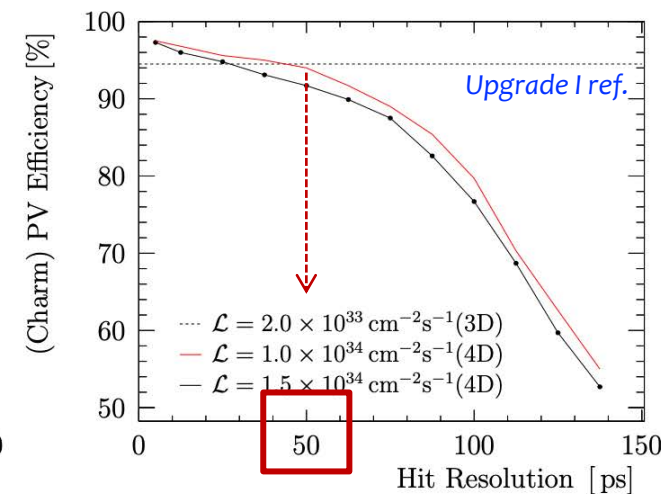
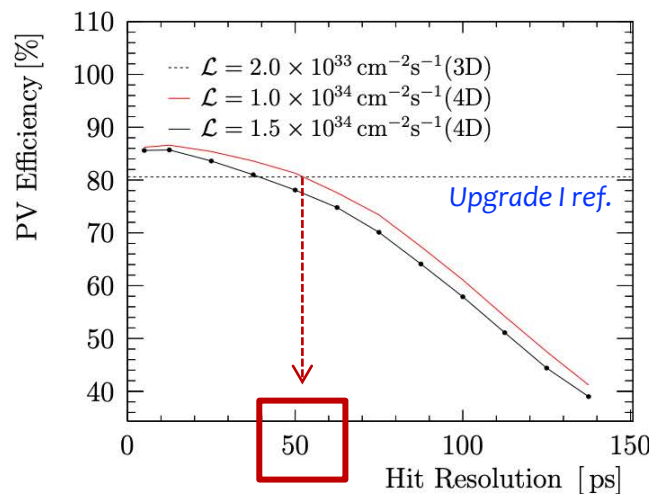
Track merging: bad Primary (and Secondary) Vertex reconstruction

Incorrect PV assigned to tracks: poorly measured lifetime
 (dominant systematic effect for time-dependent analysis)

PV reconstruction efficiency as a function of the single hit resolution, for all vertices (left) and for vertices where at least one of the decay products is a charm hadron (right).



Reconstruction efficiency vs the number of tracks per primary vertex, comparing the Upgrade I 3D reconstruction in both data conditions, and a variant using timing information to resolve the primary vertices



50 ps per hit (corresponding to 20 ps per track) are sufficient to recover the Upgrade-I efficiency

Crucial requirements for 4D-Tracking

A necessary technique for Physics at high intensity, in the next generation of upgrades in experiments at colliders: **LHCb Upgrade-II** (run5), **HIKE** (NA62 Upgrade), **CMS-PPS** (run4), **ATLAS AFP** (run5?), **ν -tagging**, **Pioneer** (proposal at PSI, π rare decays), **CMS endcap** (run5)... FCC-hh (far perspective)

1. Space Resolution $\sigma_s \approx 10 \mu\text{m}$
2. Time Resolution $\sigma_t \leq 50 \text{ ps}$ per hit
3. Radiation hardness to high fluences $\Phi = 10^{16} \div 10^{17} \text{ 1 MeV n}_{\text{eq}}/\text{cm}^2$
4. Detection efficiency $\varepsilon > 99\%$ per layer typically required (high fill factor)
5. Material budget must be kept below $1 \div 0.5\%$ radiation length per layer



Key requirements for read-out electronics:

1. Pixel pitch $\approx 50 \mu\text{m}$ (unless amplitude information for CoG techniques is used)
2. Time Resolution $\sigma_t \leq 50 \text{ ps}$ on the full chain ($\sigma_t = \sigma_{\text{sensor}} \oplus \sigma_{\text{FE}} \oplus \sigma_{\text{TDC}}$)
3. Radiation hardness TID $> 1 \text{ Grad}$
4. Power budget per pixel $\approx 25 \mu\text{W}$ (referred to $55 \mu\text{m}$ pitch, $1.5 \text{ W}/\text{cm}^2$)
5. Data BW $\approx 100 \text{ Gbps}/\text{cm}^2$

Fast and rad-hard sensors

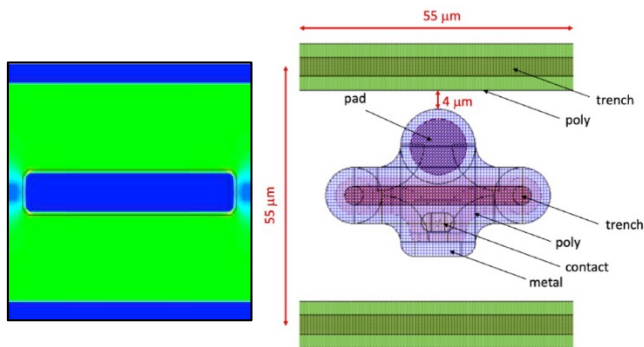
CMOS 28-nm electronics

Sensor fabrication @ FBK

2 batches (2019 and 2020)

The optimal geometry

- 3D-trench
- $5 \times 40 \times 135 \mu\text{m}^3$ trench
- $150 \mu\text{m}$ pixel depth

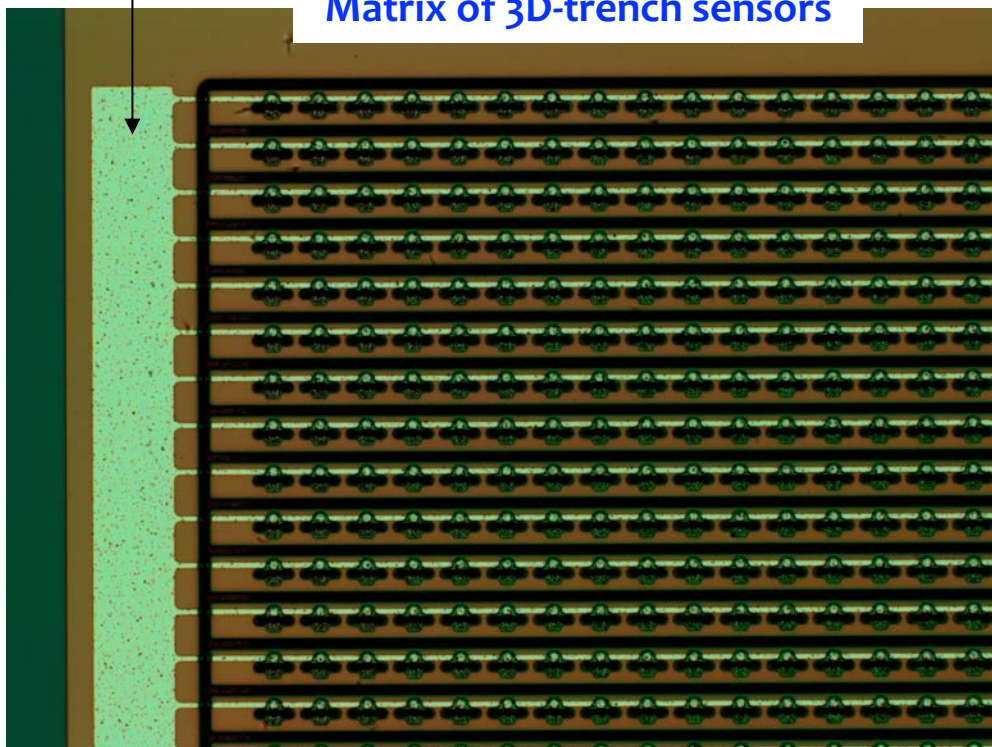


Pixel geometry

Pixel layout

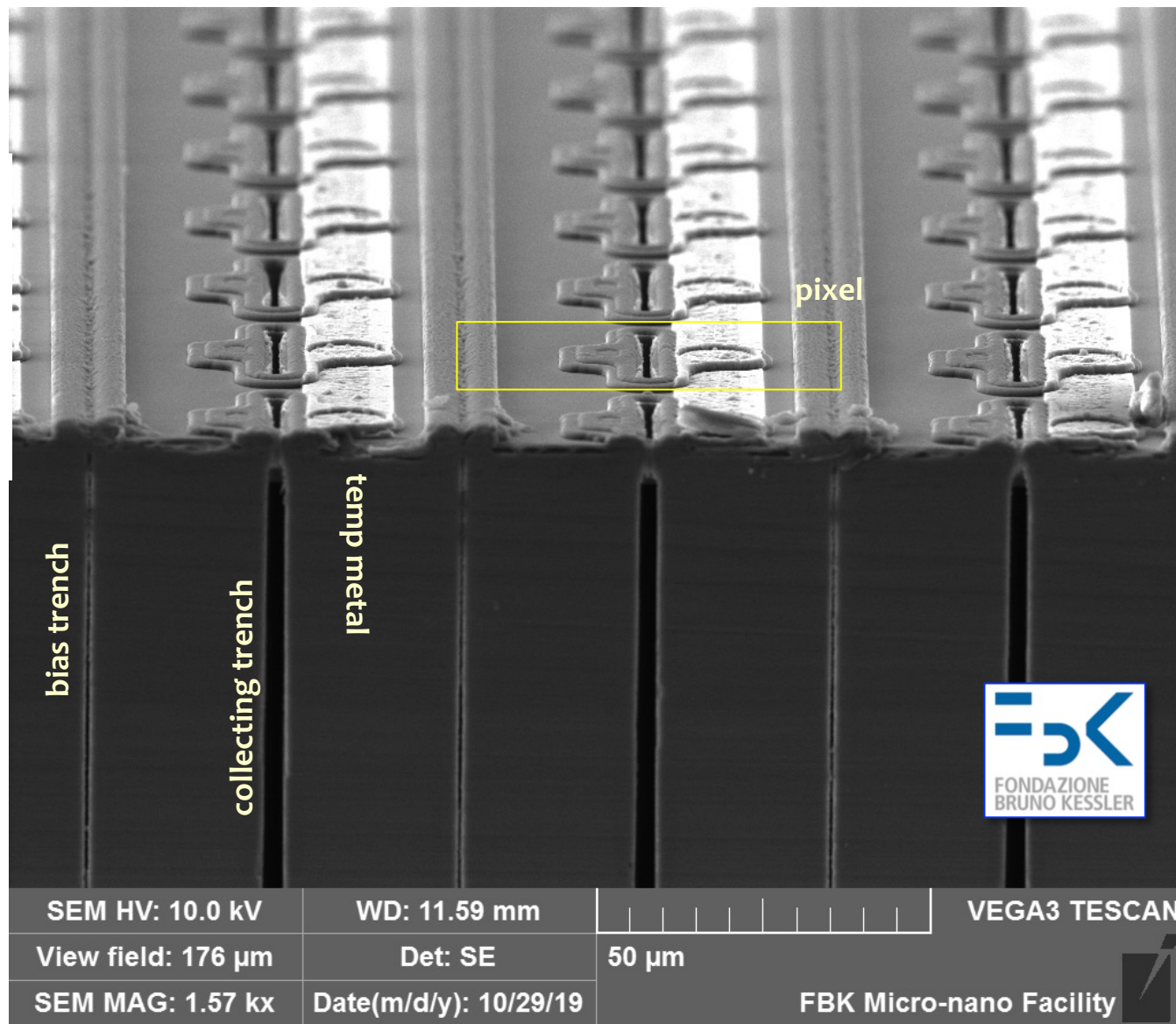
temp metal
for static tests

Matrix of 3D-trench sensors



collecting trench

bias trench

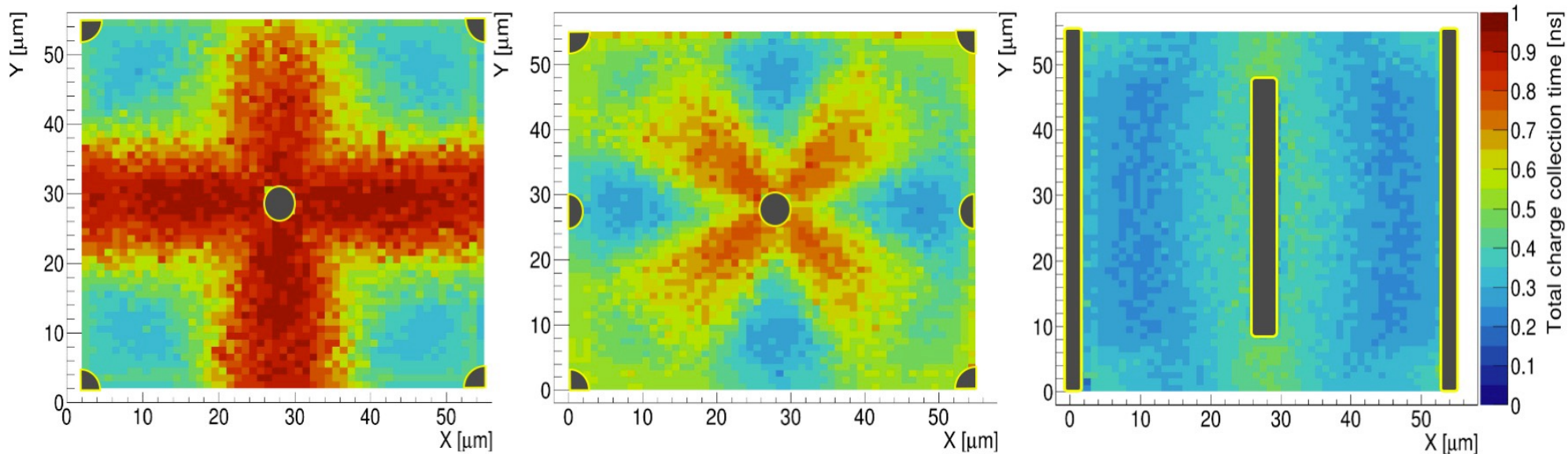
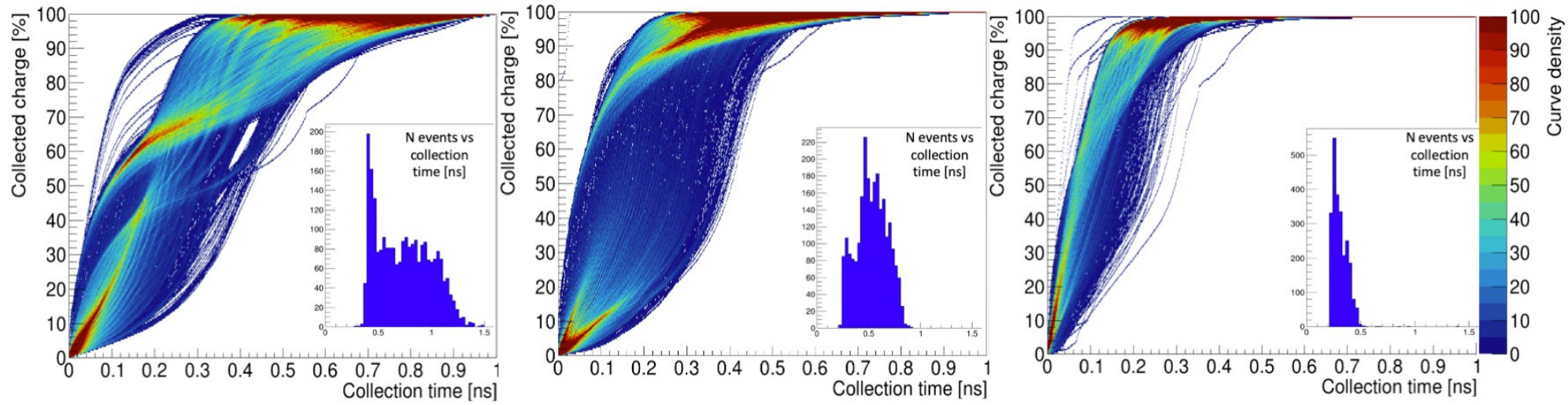
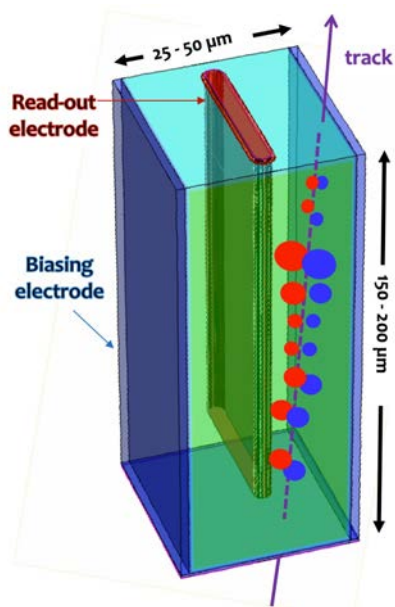


Deep Reactive Ion Etching
Bosch technology
(developed for **MicroElectroMechanicalSystem** technology)



Charge Collection Time in 3D sensors

Curves and maps



Time performance comparison among three different 3D geometries at $V_{bias} = -100V$. (Top) percentage of total charge collected on the electrodes versus time. (Top inserts) distribution of charge collection time for the three geometries. (Bottom) time for complete charge collection versus impact point for the same geometries. Each simulation is based on about 3 000 MIP tracks.

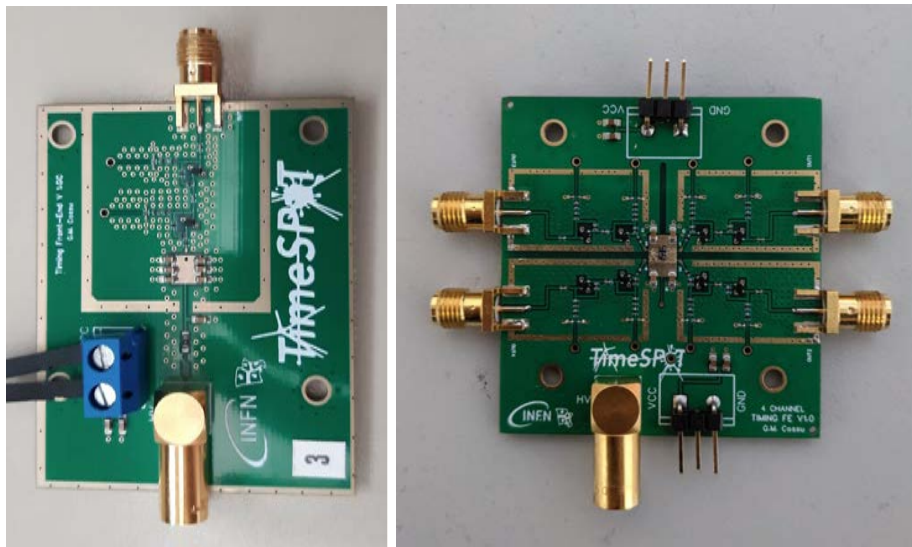
A “geometric sensor”

Latest results

Test-beams Nov21 & May-June 22 @SPS/H8

New faster dedicated front-end electronics

Si-Ge input stages
 $t_r \approx 100$ ps.
Measured jitter
< 7ps @ 2 fC
Power ≈ 70 mW/channel



1. Not-irradiated:

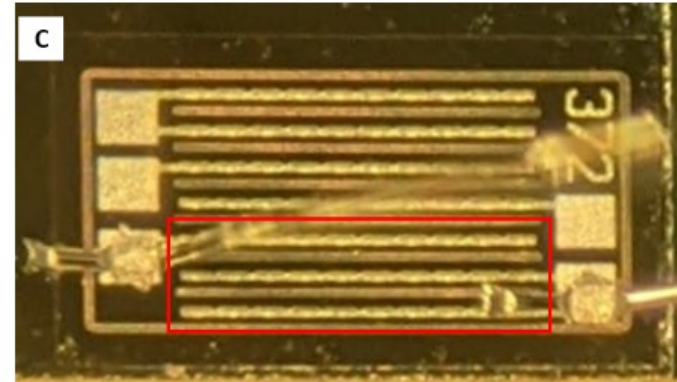
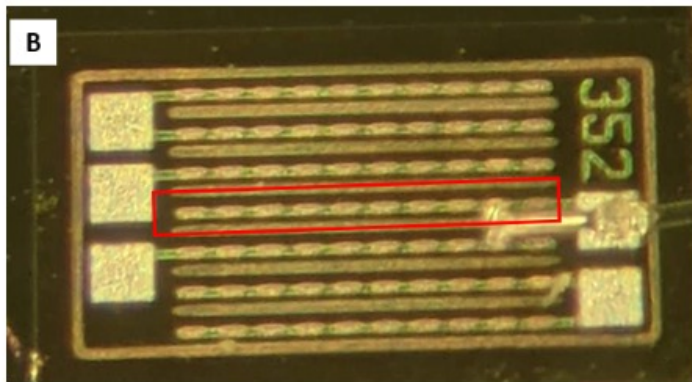
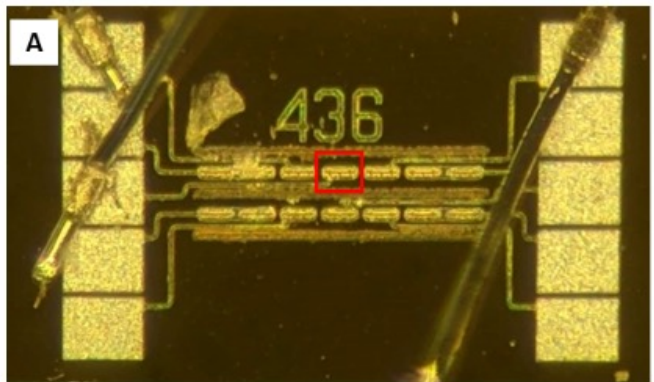
- Landau distributions vs V_{bias}
- Time resolution
- Geometrical efficiency vs tilt angle
- Time resolution vs tilt angle

2. Same with samples irradiated @ $\Phi = 2.5 \cdot 10^{16}$ 1-MeV-n/cm²

3. First studies on charge sharing

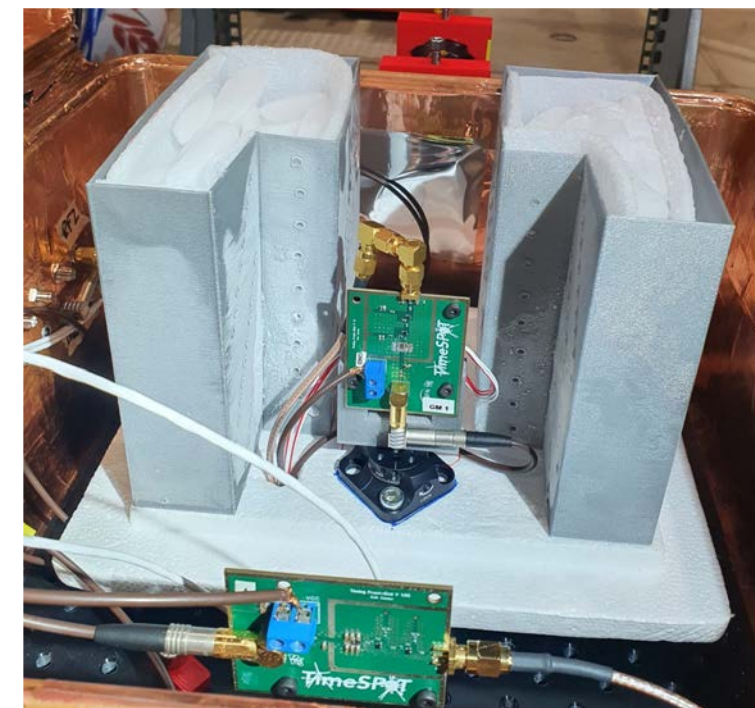
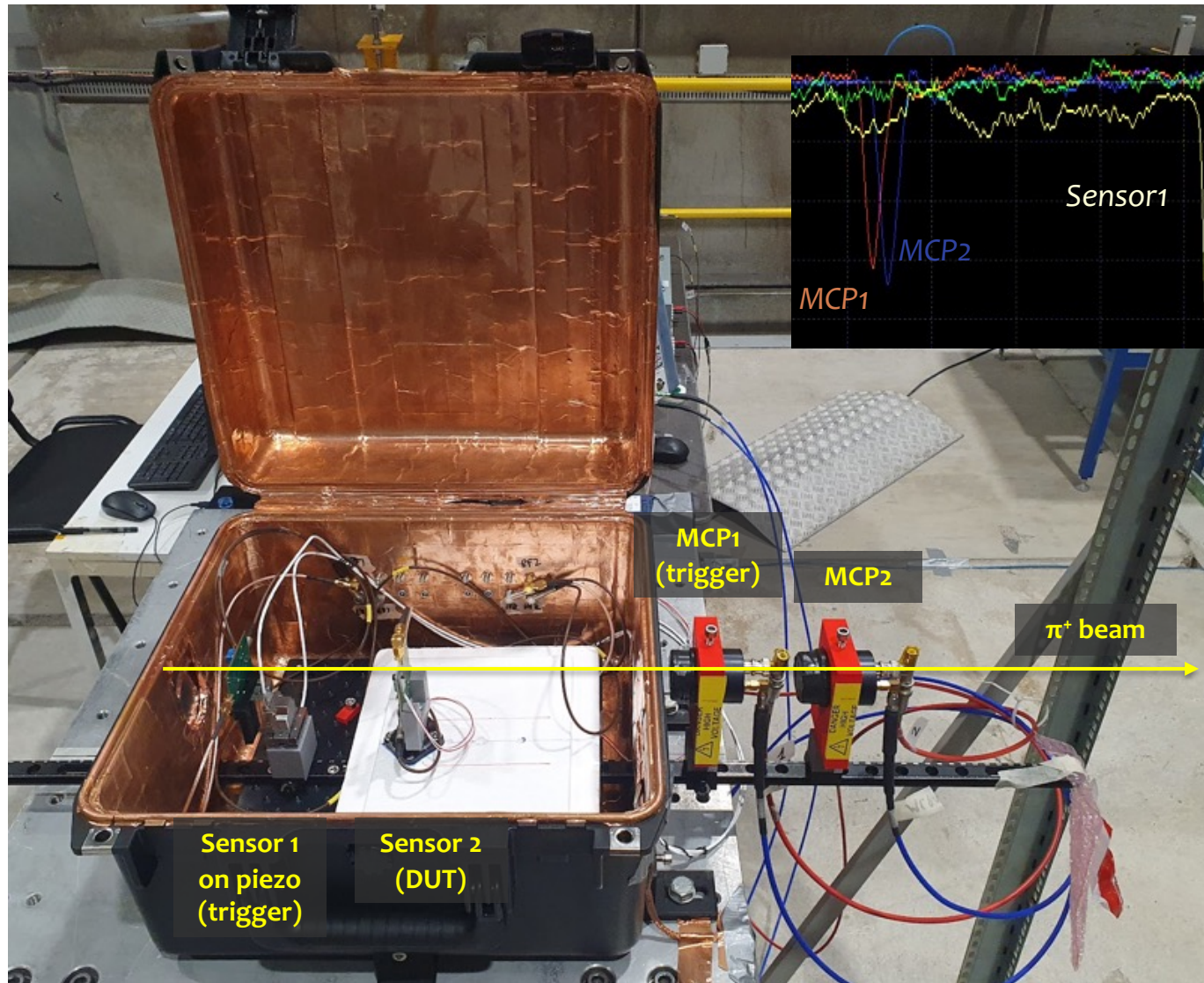
Tested structures. For each sensor the active area is shown in red.

(A) Single pixels sensor; (B) strip sensor; (C) triple strip sensor



Experimental setup

Test-beams Nov21 & May22 @SPS/H8



180 GeV/c π^+ beam

2 MCP-PMTs on the beam line to time-stamp the arriving particle ($\sigma_{\text{avg}} = 5$ ps)

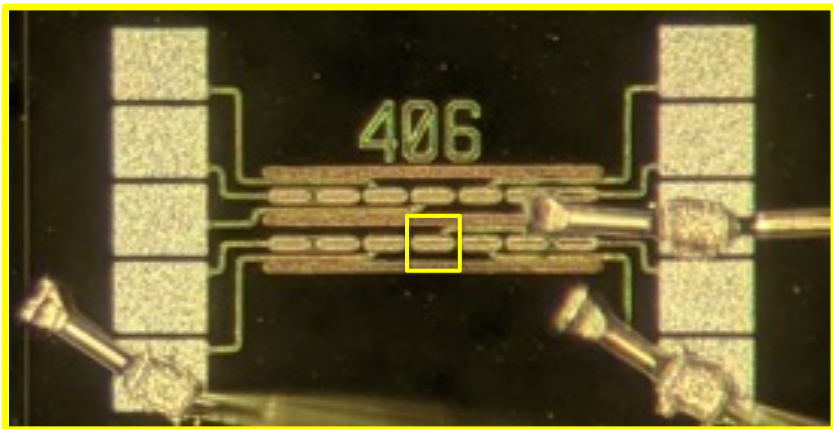
Piezoelectric stages to precisely align the two 3D structures with beam, all mounted in a RF-shielded box

Possibility of operating the fixed sensor down to -40°C using dry ice to test irradiated sensors

Readout with an 8 GHz bandwidth 20 GSa/s scope: trigger on the AND of one 3D sensor and one MCP-PMT

Amplitude distributions vs bias

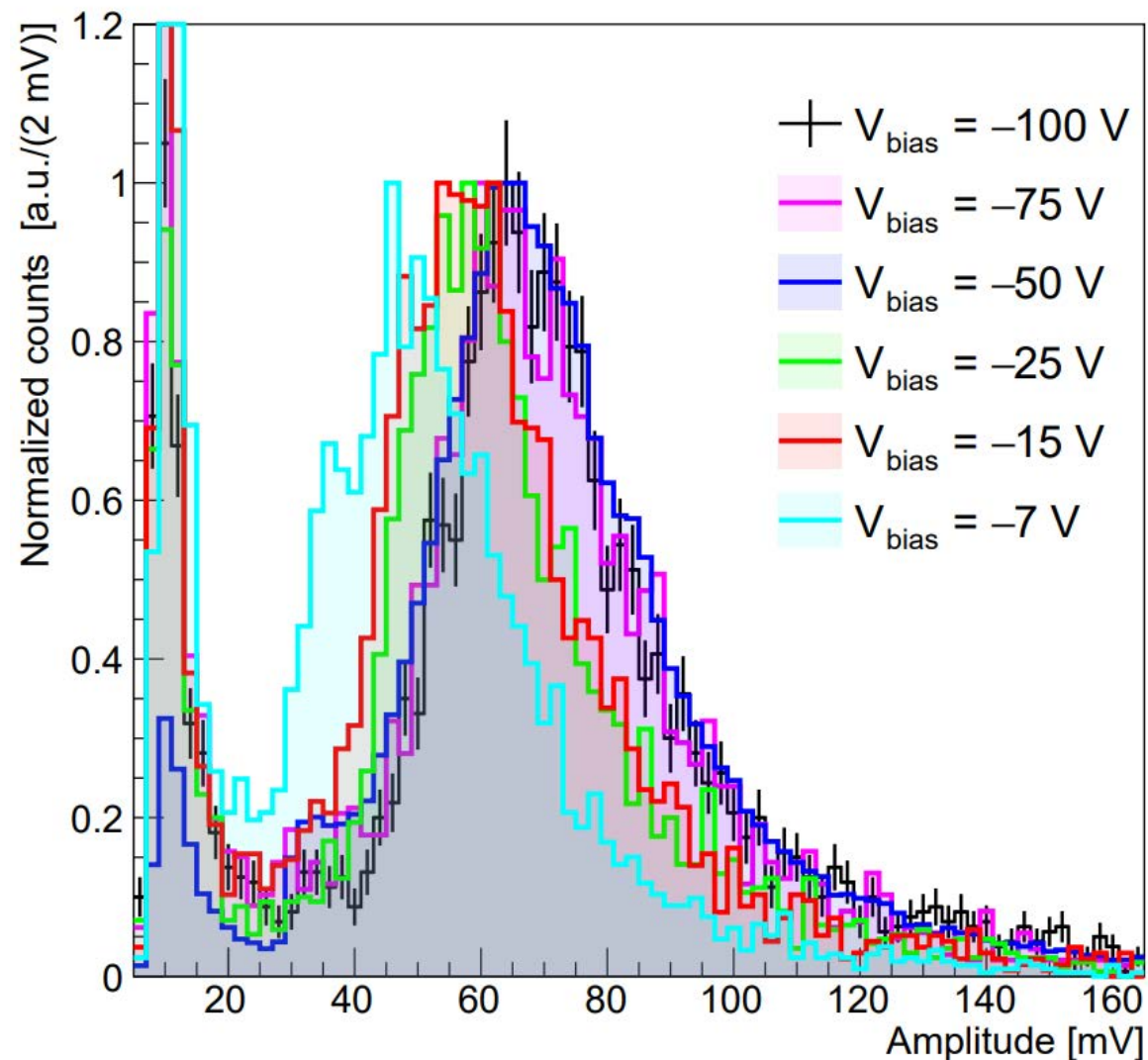
Single pixel, not irradiated



Normal pion incidence ($\alpha_{\text{tilt}} = 0^\circ$)



DUT not on the trigger

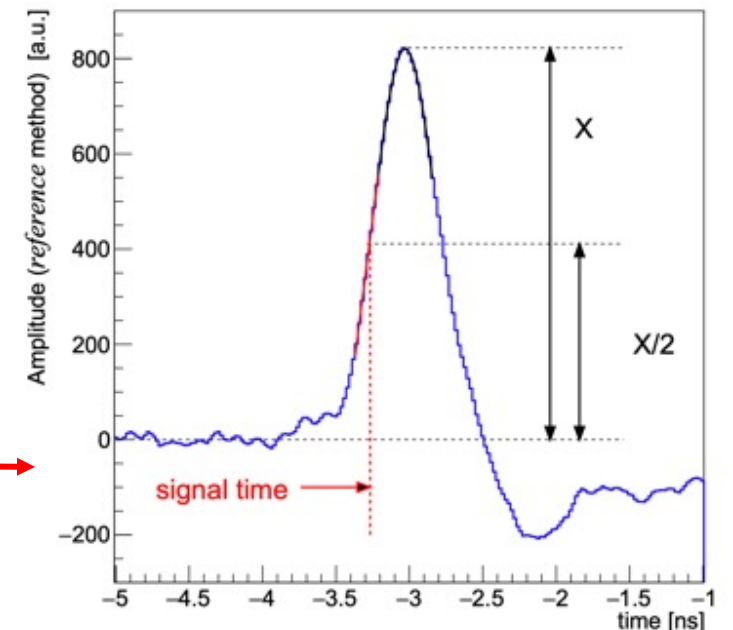
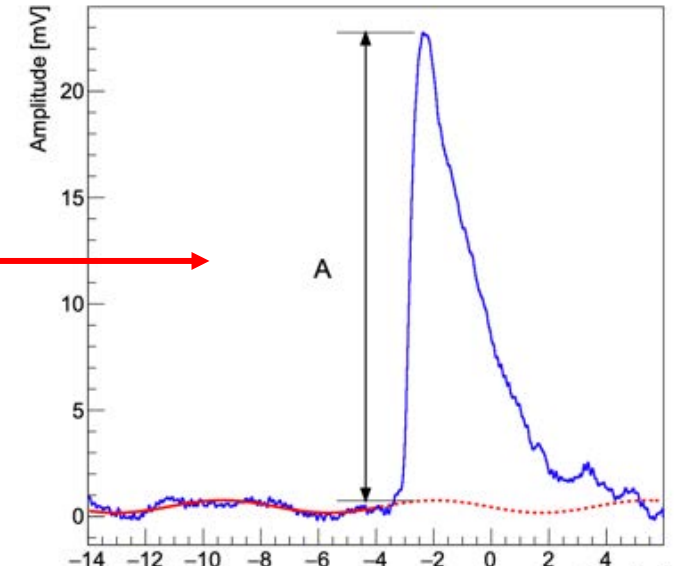
Very good sensor performance even at **low V_{bias}** (prompt full depletion)



Waveform processing for time resolution analysis

For each sensor's waveform:

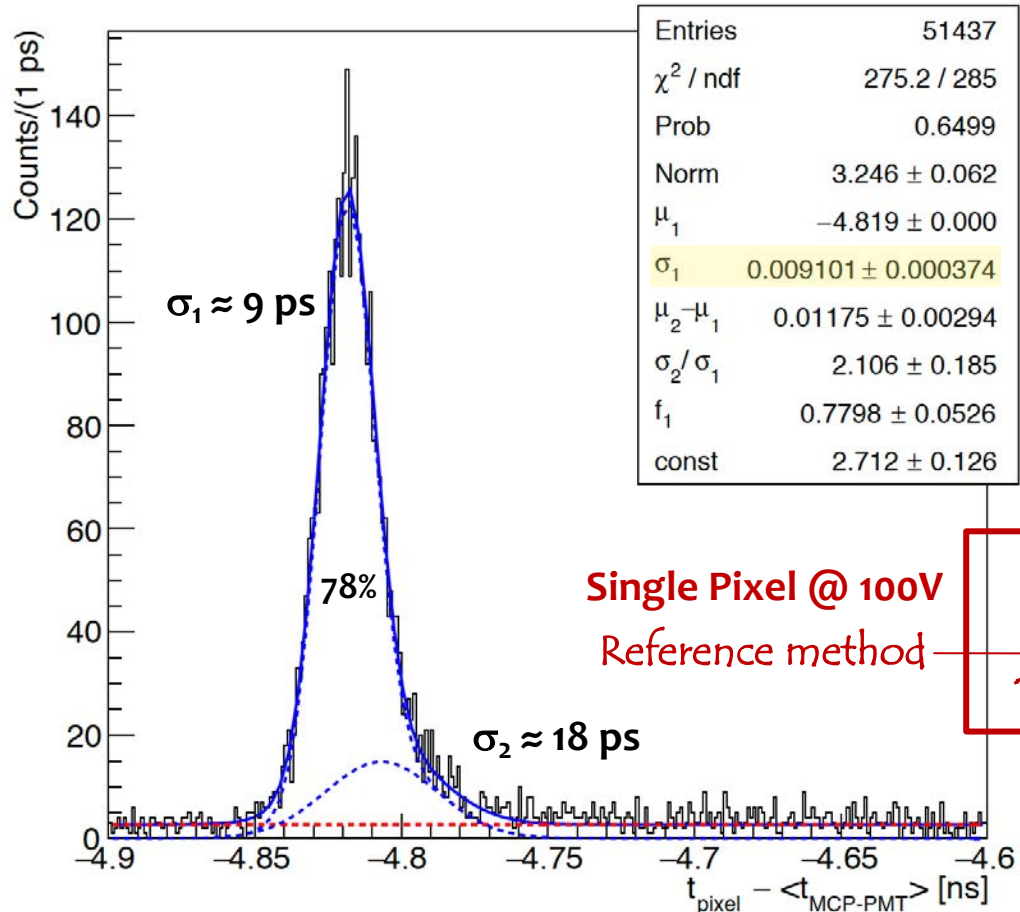
- Signal baseline (red-dashed line) is evaluated on an event-by-event basis
- The signal amplitude **A** is measured w.r.t. to the event baseline 
- Signal time of arrival evaluated with various methods:
 - **Leading-edge**: time at 15 mV signal amplitude, linear interpolation around threshold (time-walk effect is present)
 - **LE corrected for the amplitude** to suppress the time-walk effect
 - **Spline**: a classic CFD at 20% with rising edge interpolated with a spline
 - **Reference (CFD/ARC*)**: subtract each waveform from a delayed (by about half of the signal rise time) copy of itself, then, on the resulting signal, **trigger at x/2 height** 



*Amplitude and Rise-time Compensation method

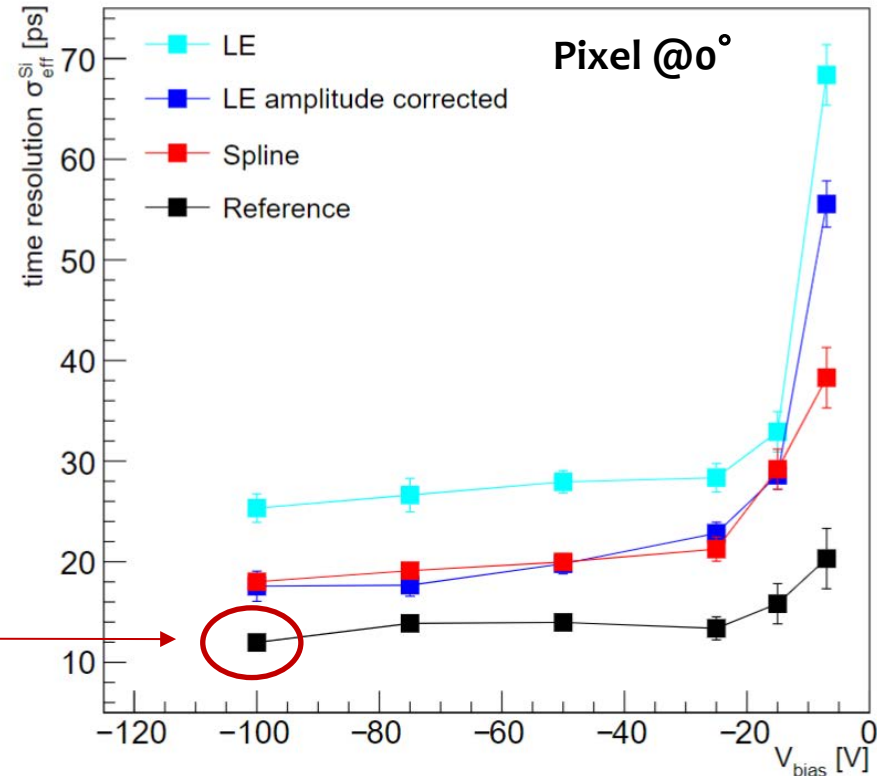
Timing measurements (single pixel @ $\alpha_{\text{tilt}} = 0^\circ$, not irradi.)

LE: Leading edge, NO ToT correction
 LE: Leading edge, ToT correction
 Spline: Classic CFD
 Reference: ARC/CFD method



Single Pixel @ 100V
Reference method

σ_t^{eff}
11.5 ps



$$(\sigma_t^{\text{eff}})^2 = f_1(\sigma_1^2 + \mu_1^2) + (1 - f_1) \cdot (\sigma_2^2 + \mu_2^2) - \mu^2$$

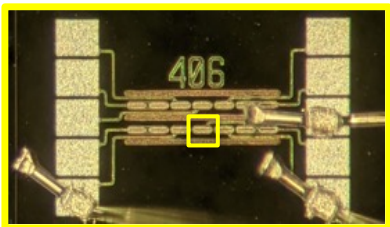
Where f_1 is the fraction of the core Gaussian and μ is defined as

$$\mu = f_1\mu_1 + (1 - f_1) \cdot \mu_2$$

σ_t^{eff} takes into account the two-Gaussian behaviour

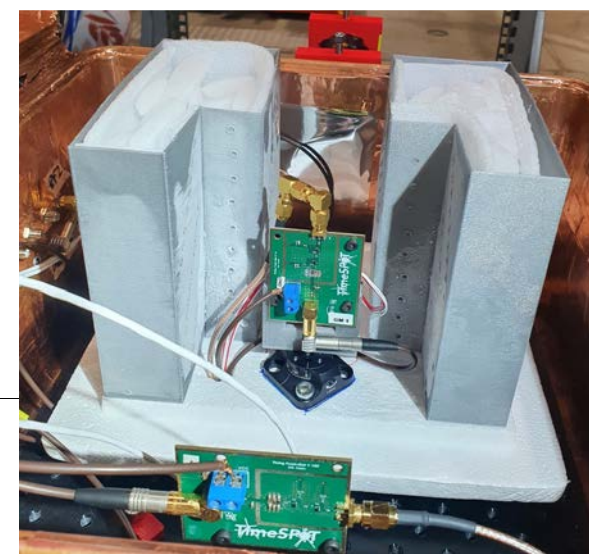
Distribution of the difference between the TOA of the single pixel and the time reference, $t_{\text{pixel}} - \langle t_{\text{MCP-PMT}} \rangle$, for the single pixel perpendicular to the beam at $V_{\text{bias}} = -100 \text{ V}$ with the reference method. The distribution is fit with the sum of two Gaussian functions (blue dashed lines) describing the signal, and a constant (red dashed line) modelling the background.

Details on the paper:
 “Charged-particle timing with 10 ps accuracy using TimesPOT 3D trench-type silicon pixels” submitted to Frontiers in Physics

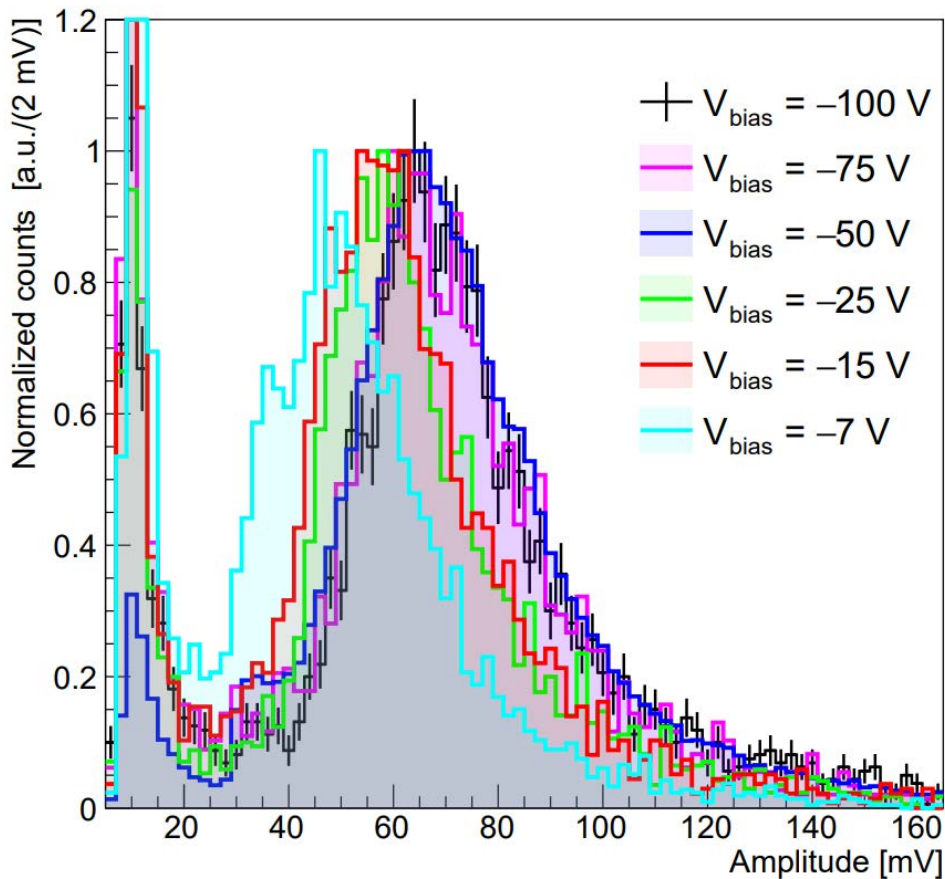


Amplitude distributions vs bias

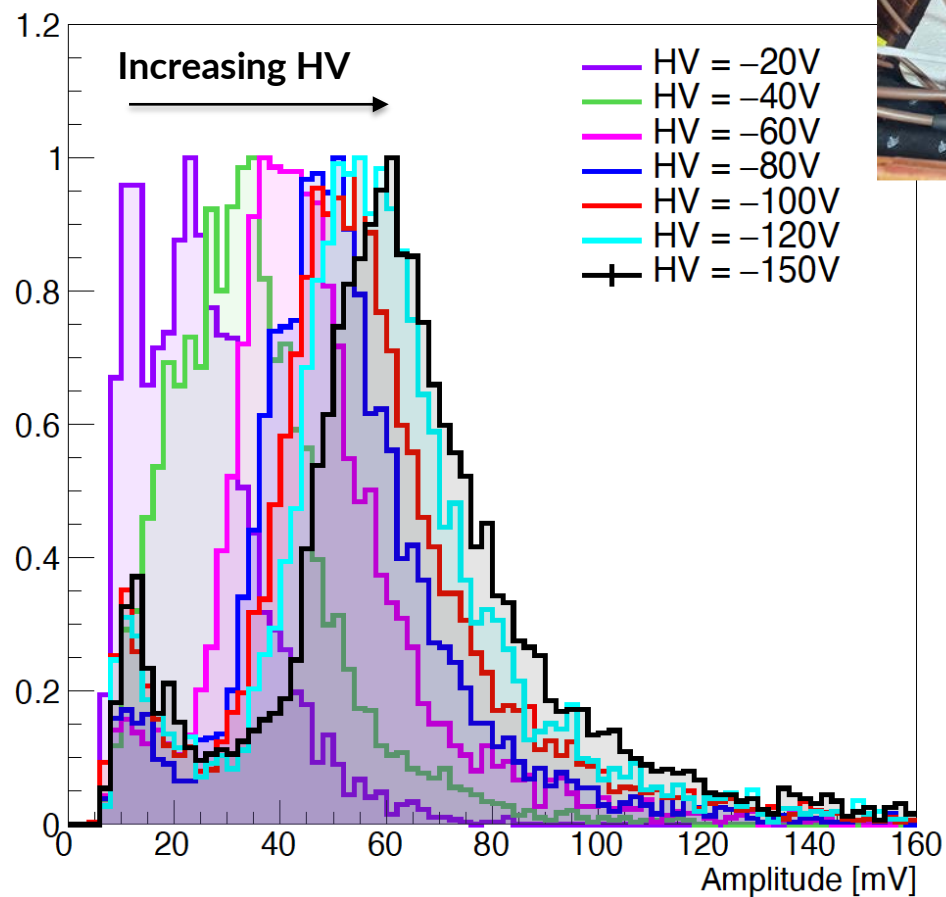
Single pixel, irradiated



Not IRRADIATED, $\alpha_{tilt} = 0^\circ$

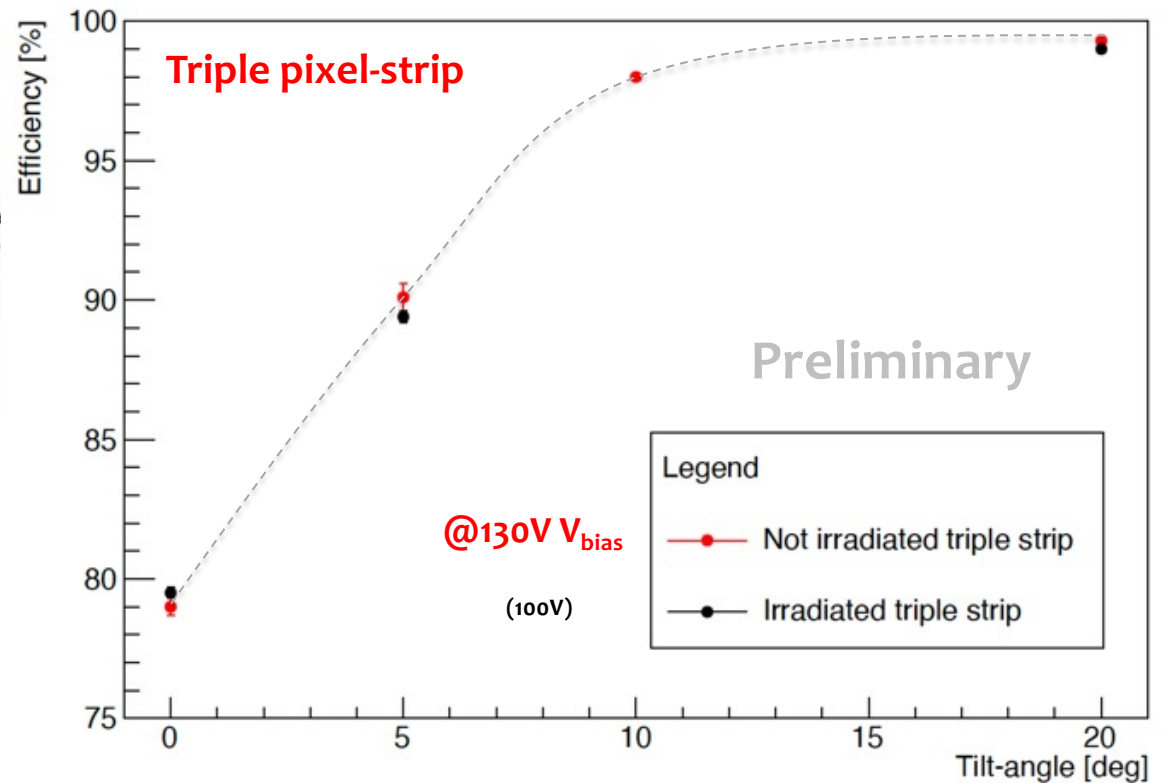
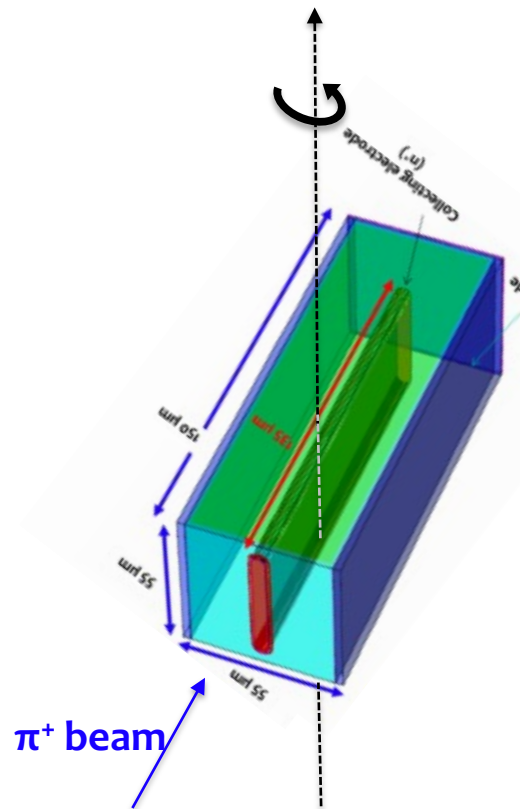
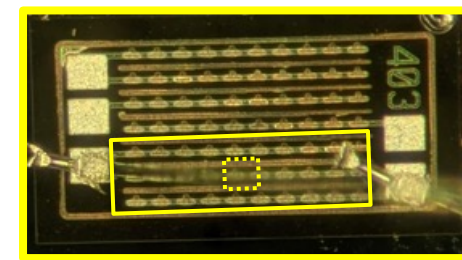


Irradiated @ $2.5 \cdot 10^{16} n_{eq}/cm^2$, $\alpha_{tilt} = 0^\circ$

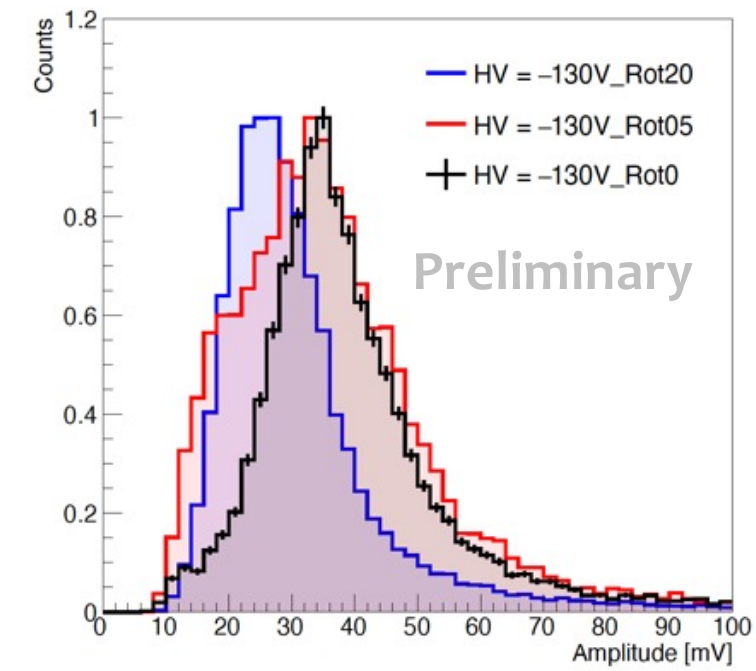


The effect of fluence is evident from the ΔV_{bias} needed to reach the same Amplitude

Irradiated/not irradiated sensors: geometrical efficiency



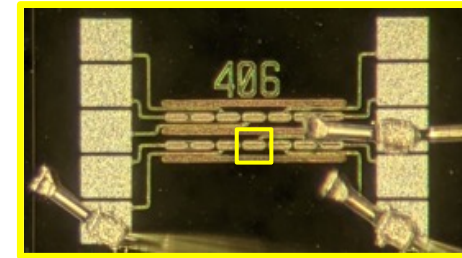
Triple strip @ $2.5 \cdot 10^{16} n_{eq}/cm^2$, $\alpha_{tilt} = 0^\circ, 5^\circ, 20^\circ$



The inefficiency (at normal incidence) due to the dead-area of the trenches is fully recovered by tilting the sensors around the trench axis

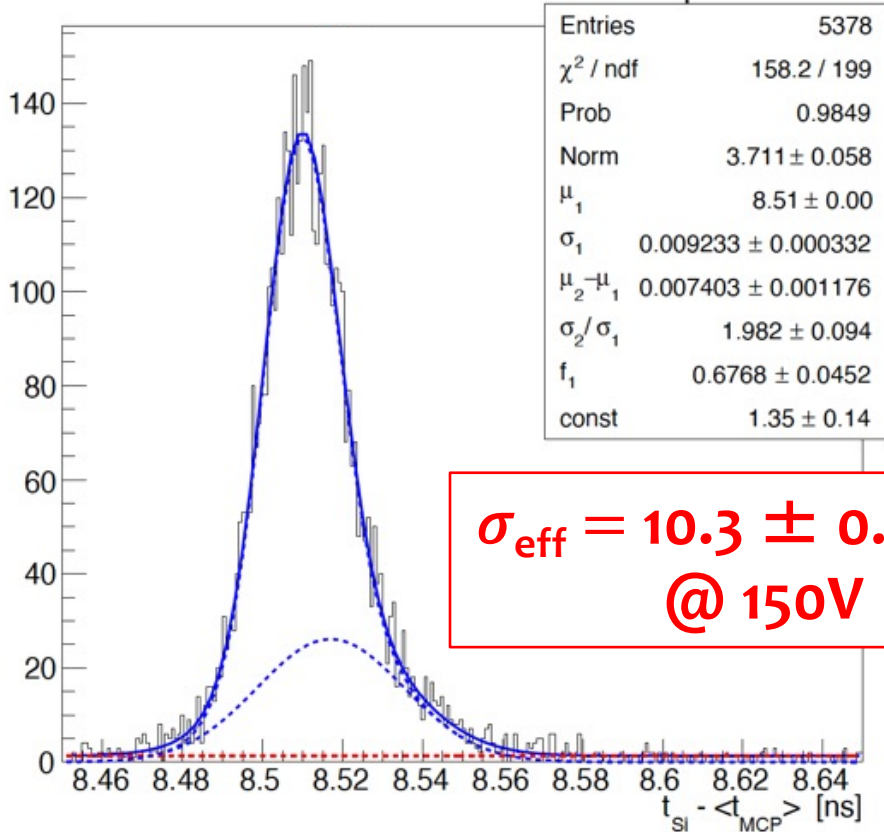
also for sensors irradiated with fluences of $2.5 \cdot 10^{16}$ 1-MeV neutron equivalent

Irradiated sensors: timing performance



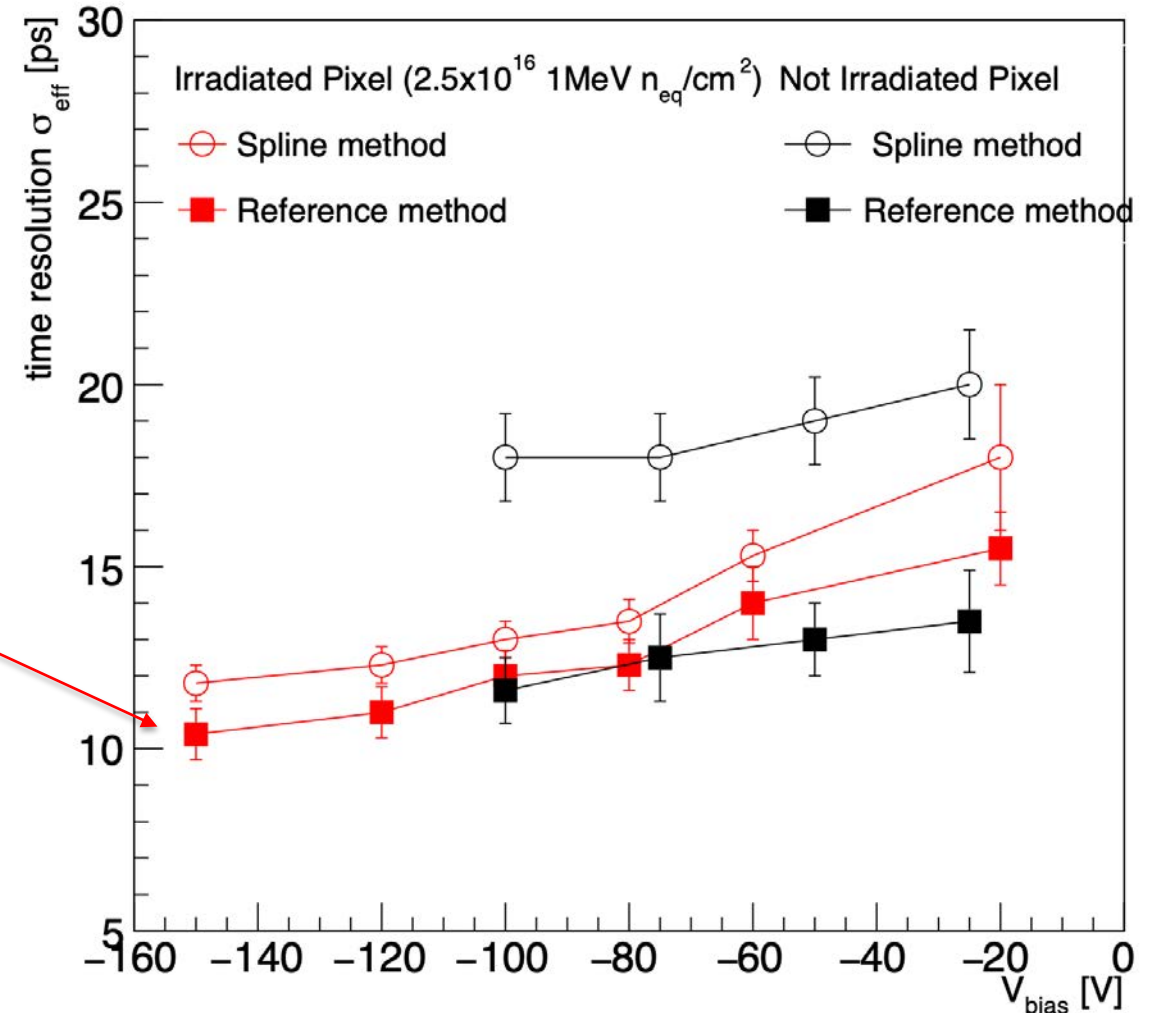
Irradiated @ $2.5 \cdot 10^{16} \text{ n}_{\text{eq}}/\text{cm}^2$, $\alpha_{\text{tilt}} = 0^\circ$

$\sigma_1 \approx 9 \text{ ps}$
 $\sigma_2 \approx 18 \text{ ps}$



$\sigma_{\text{eff}} = 10.3 \pm 0.5 \text{ ps}$
 @ 150V

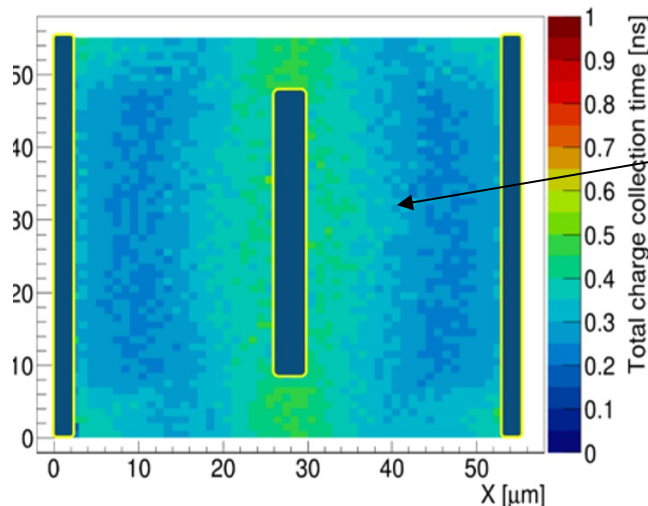
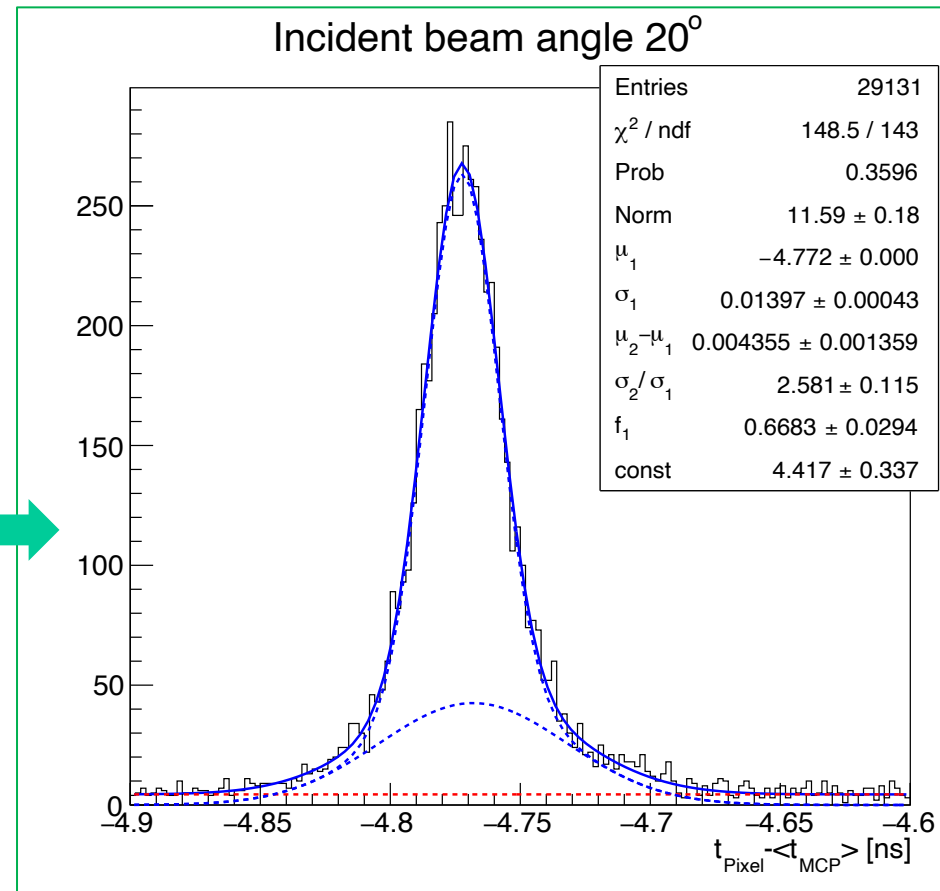
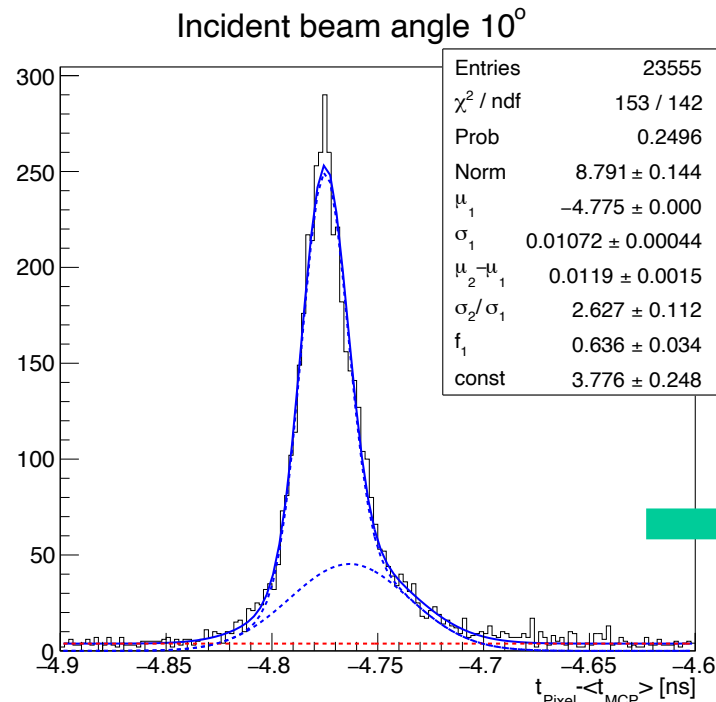
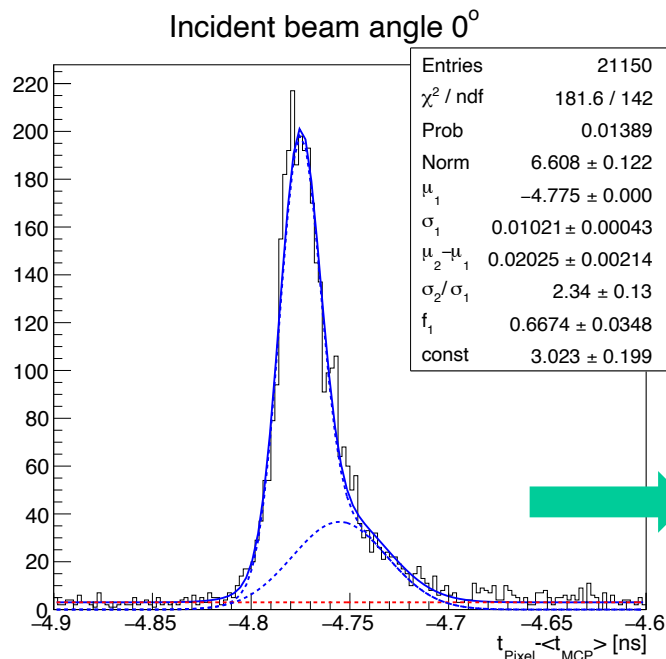
To be compared with 11 ps @ 100 V
 of the not-irradiated case



Effect of tilting on distribution shapes

Spline method, SPS/H8 (Nov'21)

Single Pixel @ 50V



Tilting has the effect of «mixing up» the fast and less-fast regions of the pixels, thus uniforming the timing response

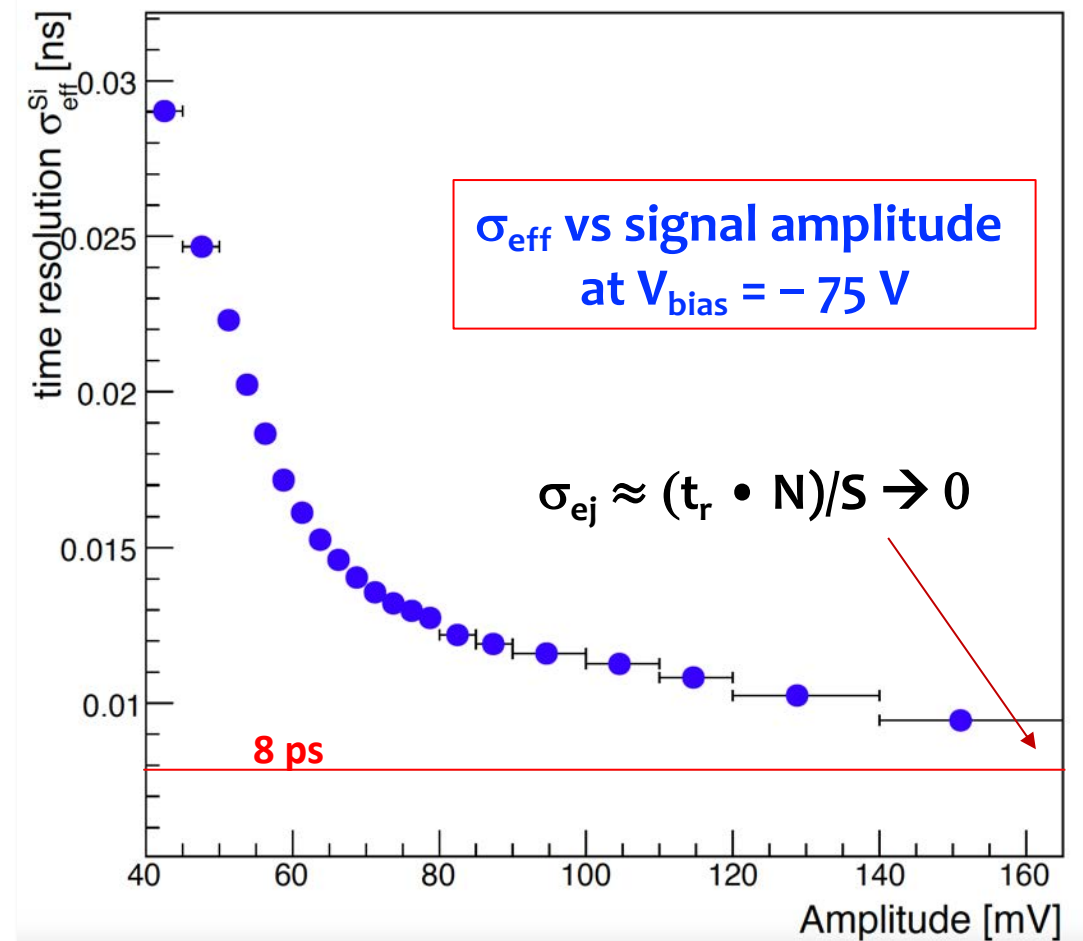
As a result, the shapes are more Gaussian at increasing α_{tilt}

Notice that, due to detection efficiency, $\alpha_{\text{tilt}} = 20^\circ$ is the normal working condition of a 3D in a detecting system

Conclusions

1. TimeSPOT 3D-trench pixel sensors show resolutions around 10 ps at fluences $\geq 2.5 \cdot 10^{16} \text{ n}_{\text{eq}}/\text{cm}^2$, with full efficiency (>99%)
2. Their intrinsic resolution are estimated in the range $8 \div 9 \text{ ps}$, also corresponding with previous simulations¹
3. Such performance is measured using high bandwidth, high power FEE
4. The final system performance will be totally dominated by the front-end ASIC² and system constraints (power)
5. As of today, 3D-trench pixels appear as the only fully-satisfying solution when timing at extreme fluences and rates is a mandatory requirement
6. Further tests at higher fluences are planned to find the resistance limit of such pixel sensors
7. Three more production batches are planned (and funded) in 2023-24

1) Brundu et al. JINST 16 (2021) P09028. doi:10.1088/1748-0221/16/09/p09028
 2) See talk #154 on the 14th this week.



The asintote ($\approx 9 \text{ ps}$) is an estimate of the intrinsic sensor contribution (when electronic jitter $\sigma_{\text{ej}} \rightarrow 0$).

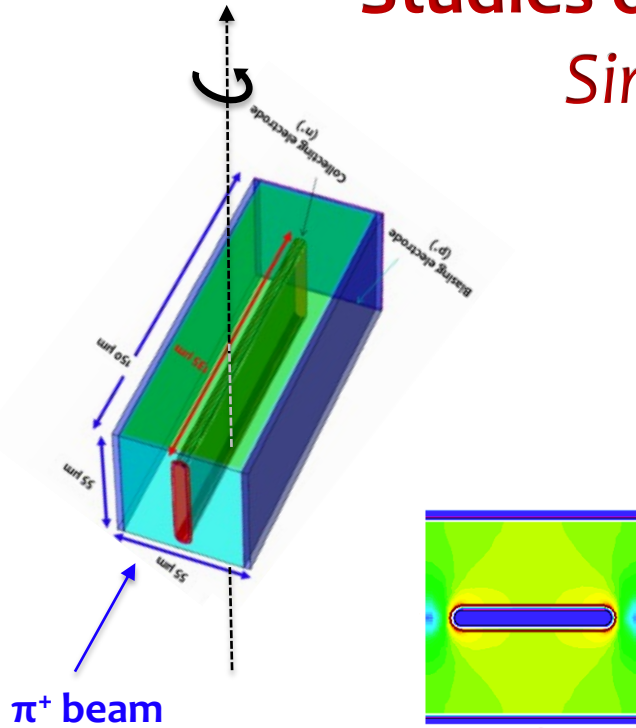
The V_{bias} can almost be increased to $\geq -100 \text{ V}$
 At $V_{\text{bias}} \approx -100 \text{ V}$, being the measured $\sigma_{\text{ej}} = 7 \text{ ps}$, we can also estimate:

$$\sigma_{\text{t,pixel}} \approx \sqrt{[11^2 - 7^2]} \approx 8.5 \text{ ps}$$

INSIGHTS

Studies of Geometric Efficiency: setup

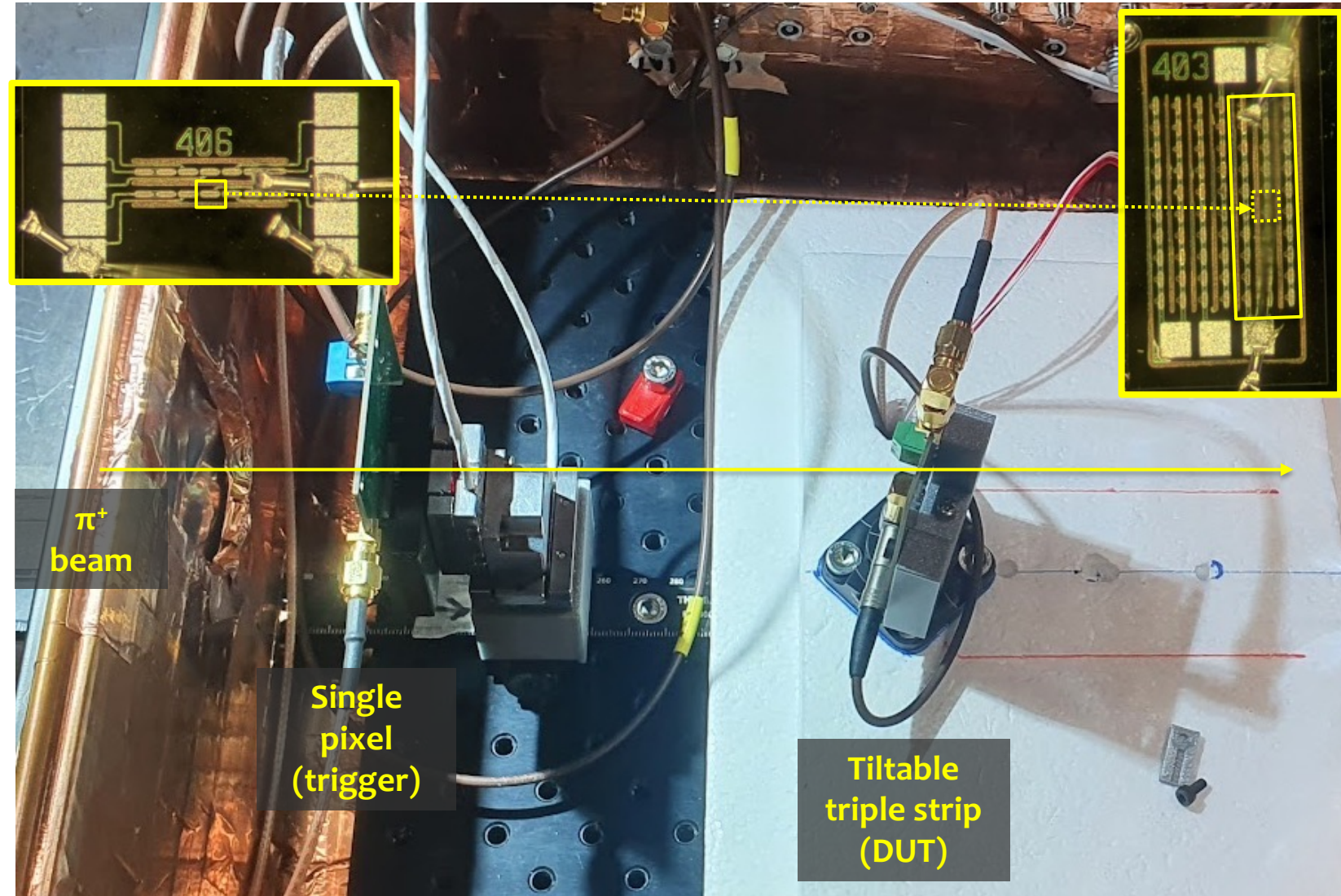
Single pixel, not irradiated



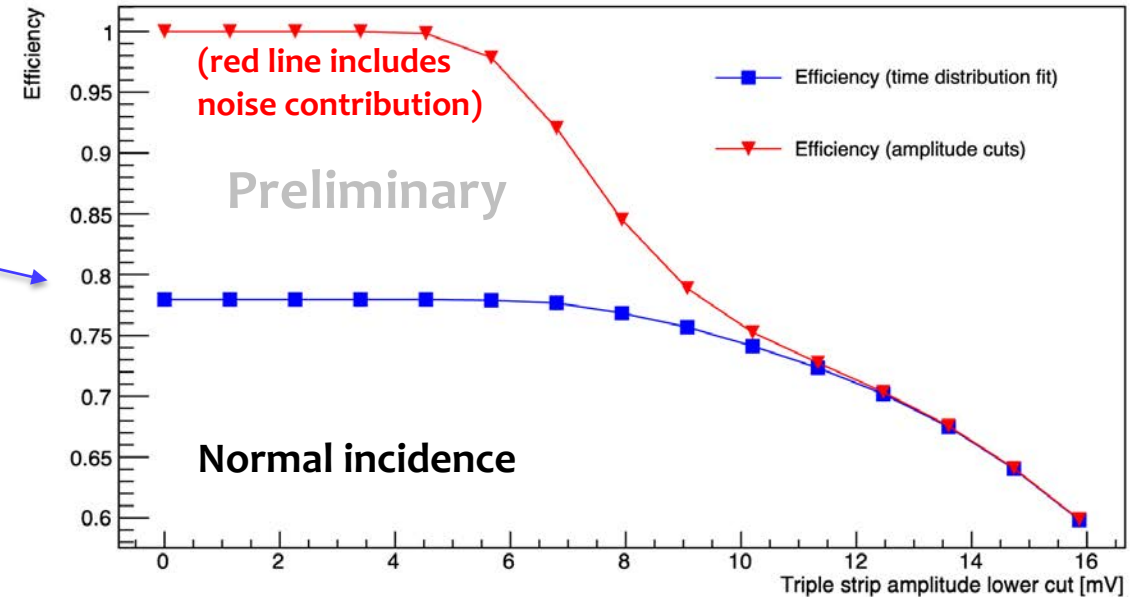
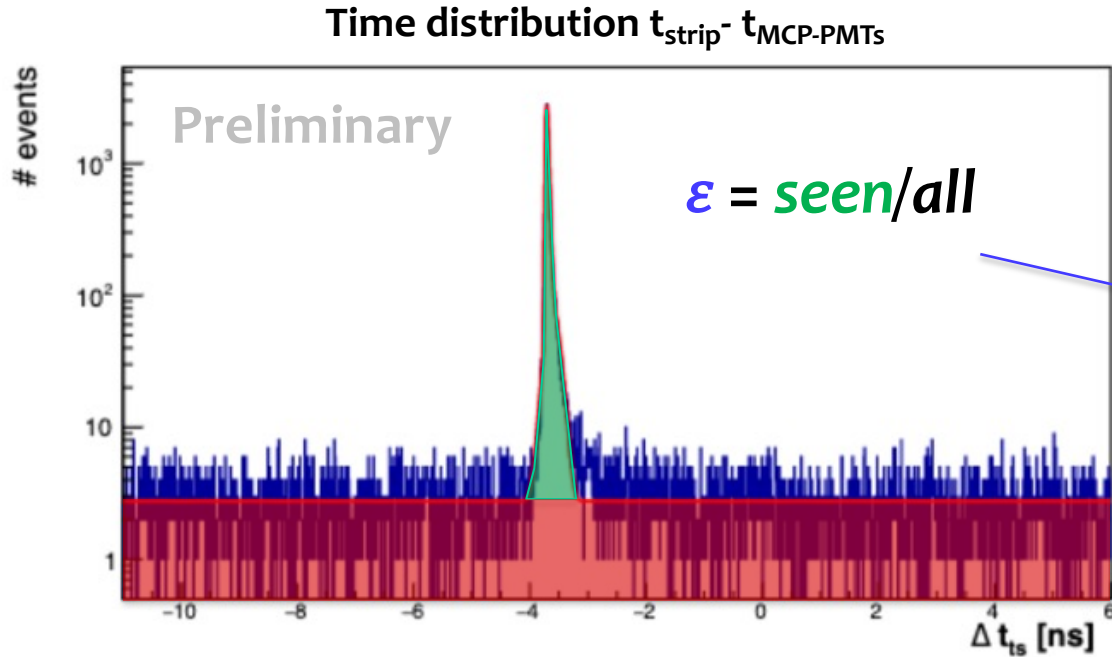
Tilting the sensors with respect to normal incidence should allow to recover geometric efficiency

Trigger on one pixel (55 μm x 55 μm , on piezos) centered on a triple strip (165 μm x 550 μm , DUT) and counting the fraction of signals seen in the triple strip (on a single FE channel)

The DUT is rotated around the trench direction

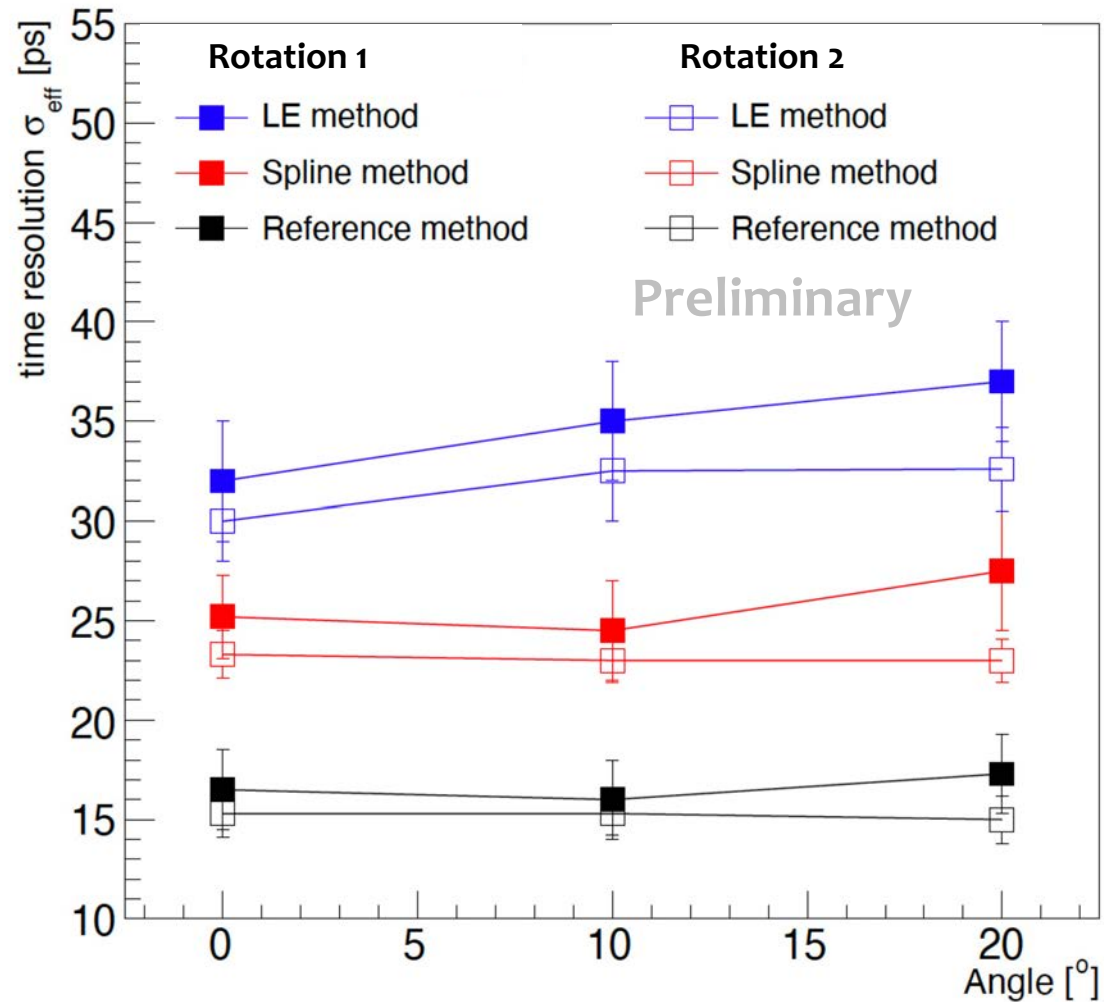
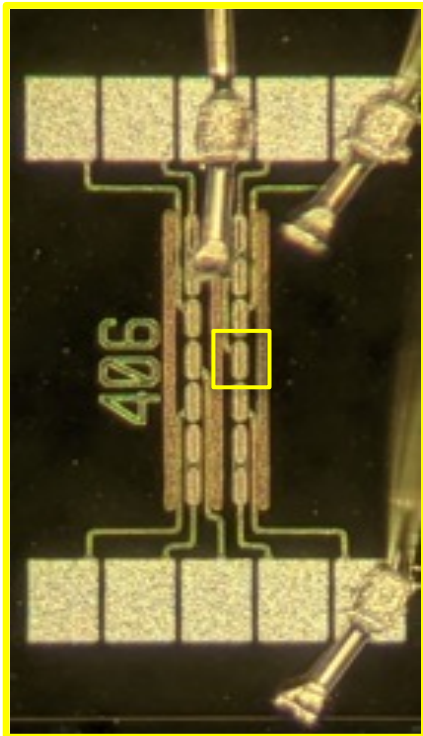


Efficiency: method

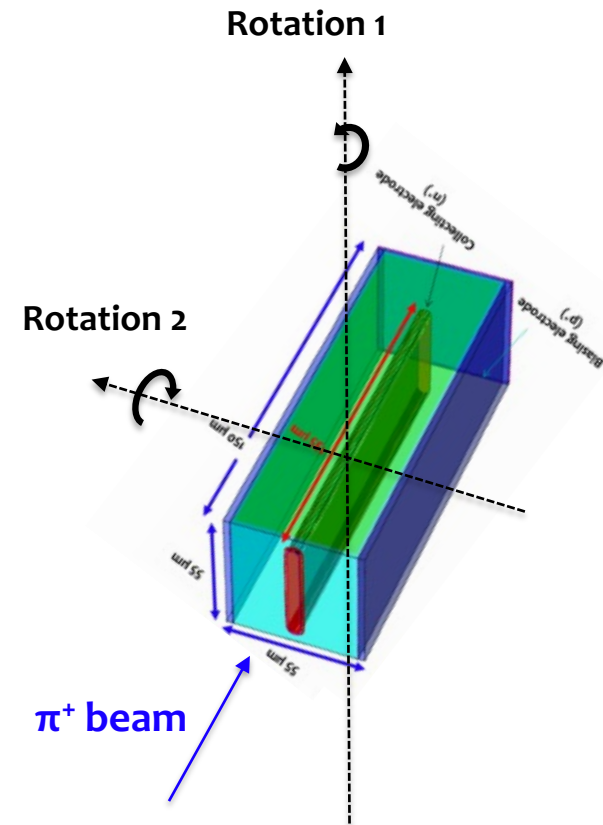


- Time distribution of **all triple-strip signals** w.r.t. MCP-PMTs and count as ‘seen’ the ones under the peak (the flat background corresponds to undetected hits)
- 3D pixel detection (geometrical) efficiency at normal incidence is **in agreement with** calculated fraction of active area ($\sim 80\%$)

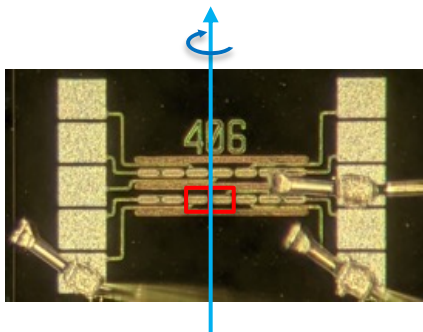
Tilted sensors: timing performance



Single Pixel @ 50V



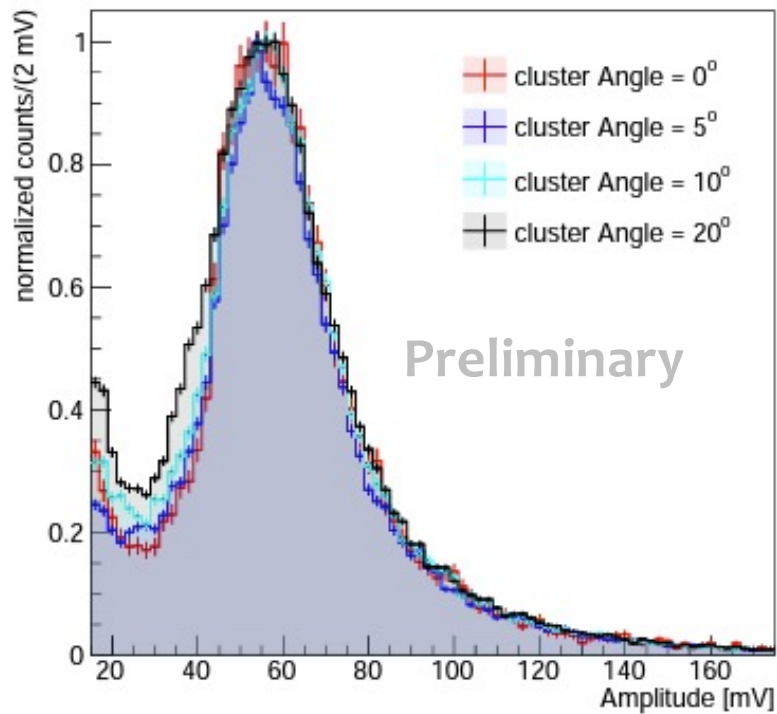
Charge sharing studies: results



When a particle crosses two pixels:

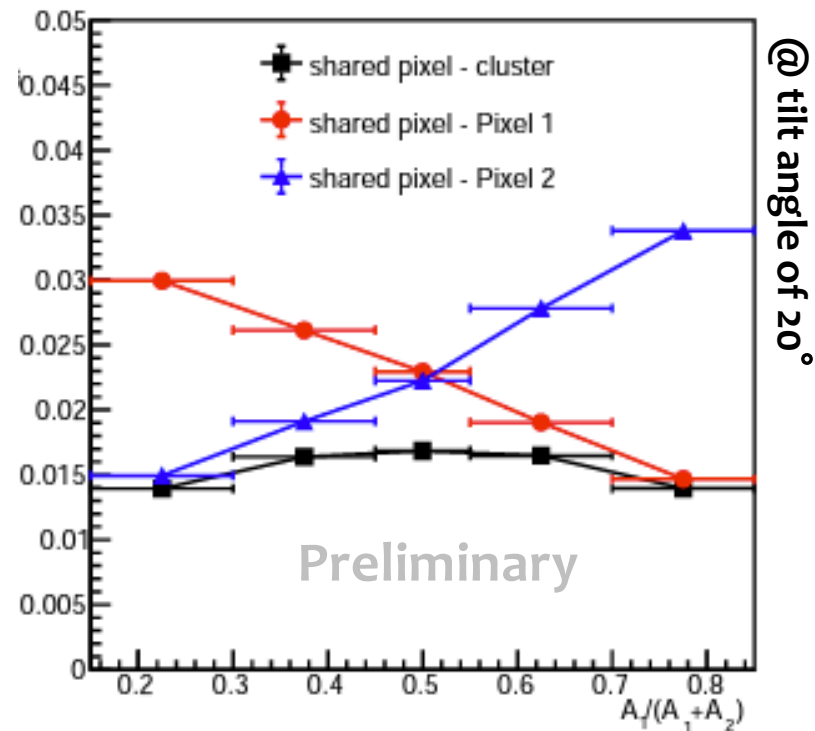
1. Amplitude = sum of the amplitudes of the two signals
2. Time of Arrival = weighted sum on amplitudes of the ToA in the two pixels

Amplitude distributions at different angles



Combining the two pixels information, it is possible to recover the amplitude distribution expected at normal incidence angle

Time resolution as a function of the fraction of sharing



Using the information of both pixels, timing performance improves

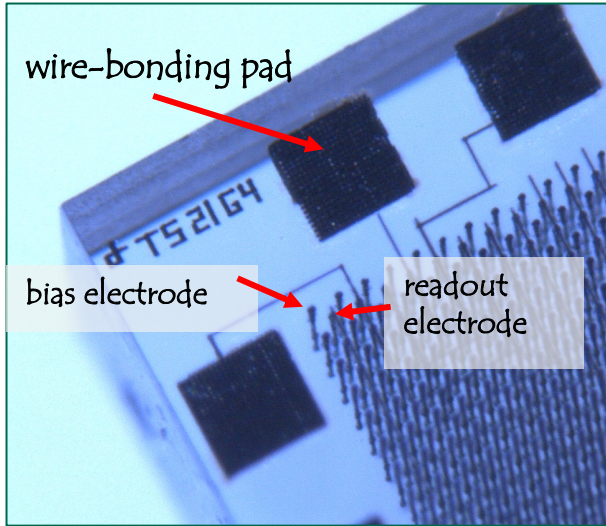
*time resolution from histogram RMS

Time resolution of 3D-column diamond sensors

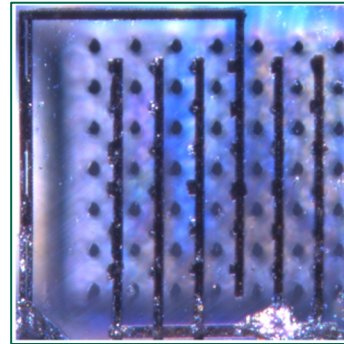
By TimeSPOT Firenze group

Single pixel

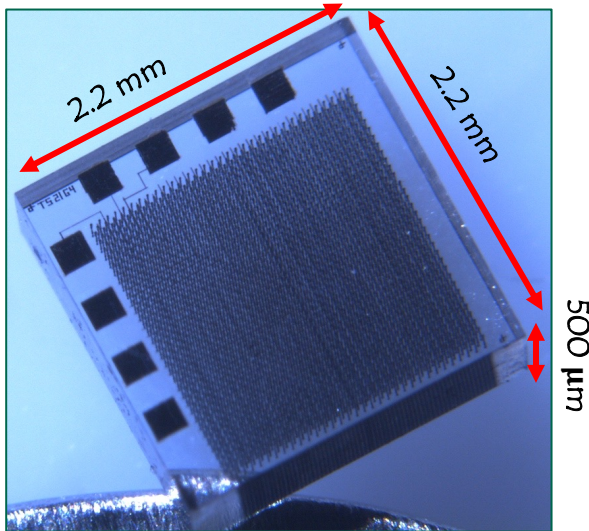
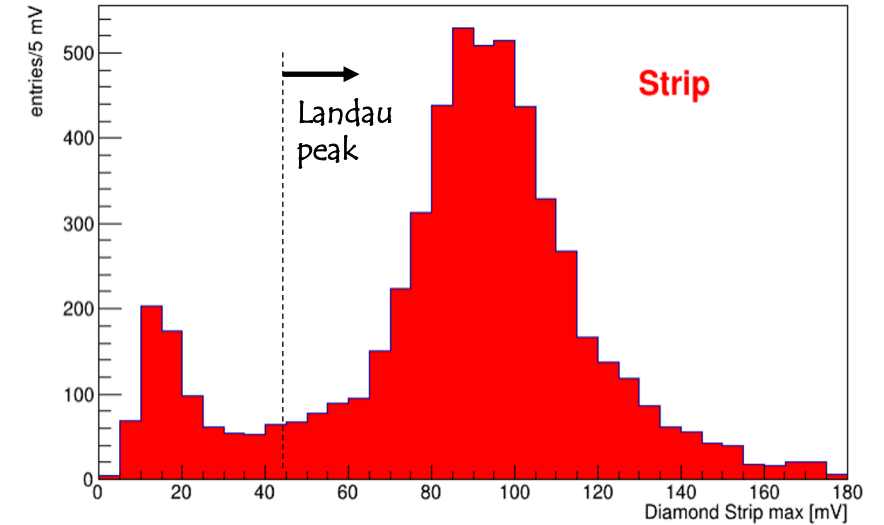
S/N = 18



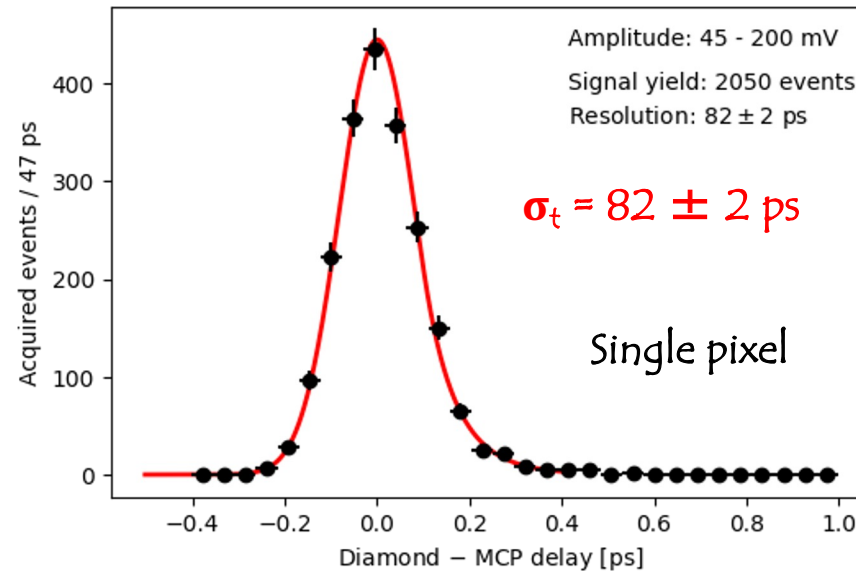
Prototype 32x32 55x55 μm^2 sensor for test-beam



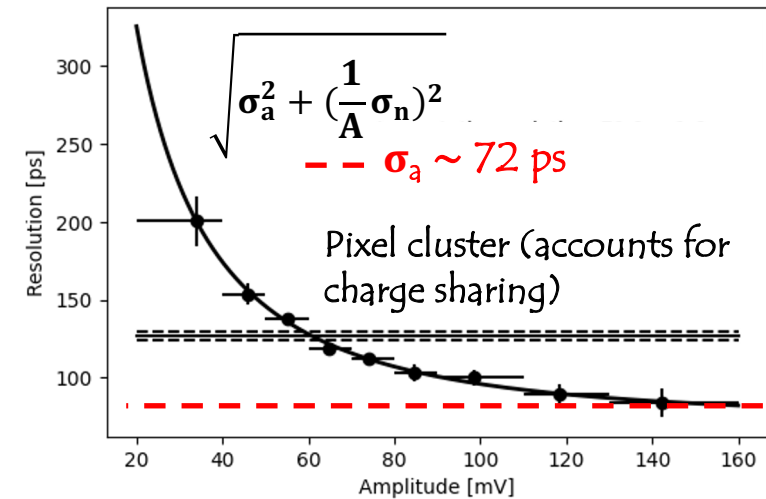
TimeSPOT Silicon pixel or strip used for trigger and scanning of the diamond sensor



Single crystal CVD diamond by E6



Time resolution



σ_a gives an estimate of the intrinsic sensor resolution